

## Description

The AP2501A and AP2511A are single channel, current-limited, integrated, high-side power switches optimized for Universal Serial Bus (USB) and other hot-swap applications. This family of devices complies with USB standards and is available with both polarities of Enable input.

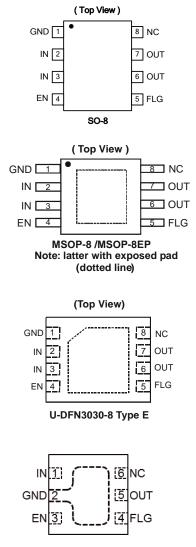
The devices have fast short-circuit response time for improved overall system robustness, and have integrated output discharge function to ensure completely controlled discharging of the output voltage capacitor. They provide a complete protection solution for applications subject to heavy capacitive loads and the prospect of short circuit, and offer reverse current blocking, over-current, over-temperature and short-circuit protection, and controlled rise time and undervoltage lockout functionality. A 7ms deglitch capability on the opendrain Flag output prevents false over-current reporting and does not require any external components.

All devices are available in SO-8, MSOP-8, MSOP-8EP, U-DFN3030-8 and U-DFN2020-6 packages.

### Features

- Single Channel Current-Limited Power Switch
- Output Discharge Function
- Fast Short-Circuit Response Time: 2µs
- 2.5A Accurate Current Limiting
- Reverse Current Blocking
- 70mΩ on-Resistance
- Input Voltage Range: 2.7V 5.5V
- Built-in Soft-Start with 0.6ms Typical Rise Time
- Over-Current and Thermal Protection
- Fault Report (FLG) with Blanking Time (7ms typ)
- ESD Protection: 2kV HBM, 200V MM
- Ambient Temperature Range: -40°C to +85°C
- SO-8, MSOP-8, MSOP-8EP, U-DFN3030-8 and U-DFN2020-6: Available in "Green" Molding Compound (No Br, Sb)
- Totally Lead-free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- UL Recognized, File Number E322375
- IEC60950-1 CB Scheme Certified

### **Pin Assignments**



U-DFN2020-6

### Applications

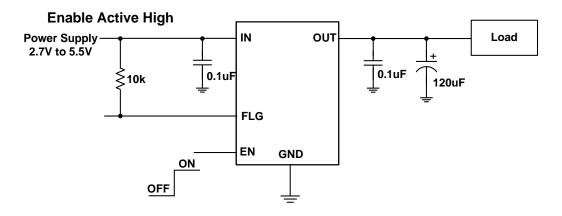
- LCD TVs & Monitors
- Set-Top Boxes, Residential Gateways
- Laptops, Desktops, Servers, E-Readers, Printers, Docking Stations, HUBs

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  - 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.



# **Typical Applications Circuit**



#### **Available Options**

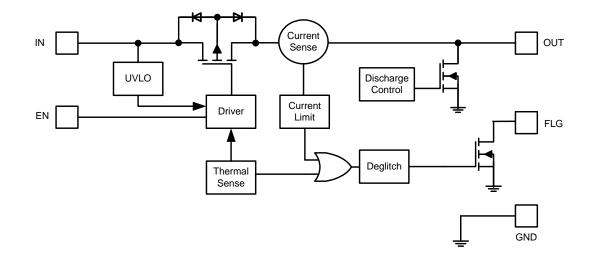
Part Number	Channel	Enable Pin (EN)	Recommended Maximum Continuous Load Current (A)	Typical Current Limit (A)	Package
AP2501A	1	Active Low		0.54	SO-8 MSOP-8
AP2511A	1	Active High	2A	2.5A	MSOP-8EP U-DFN3030-8 U-DFN2020-6

## **Pin Descriptions**

Pin		Pin Numbe	r	
Name	SO-8, MSOP-8	MSOP-8EP, U-DFN3030-8	U-DFN2020-6	Function
GND	1	1	2	Ground
IN	2, 3	2, 3	1	Voltage Input Pin Connect a $0.1\mu$ F or larger ceramic capacitor from IN to GND as close as possible. (all IN pins must be tied together externally)
EN	4	4	3	Enable input, active low (AP2501A) or active high (AP2511A)
FLG	5	5	4	Over-temperature and over-current fault reporting with 7ms deglitch; active low open- drain output. FLG is disabled for 7ms after turn-on.
OUT	6, 7	6, 7	5	Voltage Output Pin All OUT pins must be tied together externally.
NC	8	8	6	NC: No Internal Connection; recommend tie to OUT pins
Exposed Pad	_	Exposed Pad	Exposed Pad	Exposed Pad It should be externally connected to GND and thermal mass for enhanced thermal impedance. It should not be used as electrical ground conduction path.



## **Functional Block Diagram**



## Absolute Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Parameter	Ratings	Unit
ESD HBM	Human Body Model ESD Protection	2	kV
ESD MM	Machine Model ESD Protection	200	V
V <sub>IN</sub>	Input Voltage (Note 4)	-0.3 to 6.5	V
V <sub>OUT</sub>	Output Voltage (Note 4)	-0.3 to (V <sub>IN</sub> +0.3) or 6.5	V
$V_{\text{EN}}$ , $V_{\text{FLG}}$	Enable Voltage (Note 4)	-0.3 to (V <sub>IN</sub> +0.3) or 6.5	V
I <sub>LOAD</sub>	Maximum Continuous Load Current	Internal Limited	A
T <sub>J(MAX)</sub>	Maximum Junction Temperature	+150	C°
T <sub>ST</sub>	Storage Temperature Range (Note 5)	-65 to +150	C°

Notes: 4. All voltages referred to GND pin. Maximums are the lower of ( $V_{IN}$  +0.3) and 6.5V.

5. UL Recognized Rating from -30°C to +70°C (Diodes qualified T<sub>ST</sub> from -65°C to +150°C).

Caution: Stresses greater than the 'Absolute Maximum Ratings' specified above may cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions exceeding those indicated in this specification is not implied. Device reliability may be affected by exposure to absolute maximum rating conditions for extended periods of time.

Semiconductor devices are ESD sensitive and may be damaged by exposure to ESD events. Suitable ESD precautions should be taken when handling and transporting these devices.

### Recommended Operating Conditions (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Parameter	Min	Max	Unit
VIN	Input Voltage	2.7	5.5	V
I <sub>OUT</sub>	Output Current	0	2	А
VIL	EN Input Logic Low Voltage	0	0.8	V
VIH	EN Input Logic High Voltage	2	V <sub>IN</sub>	V
TA	Operating Ambient Temperature	-40	+85	°C



Symbol	Parameter	Test Con	ditions	Min	Тур	Max	Unit
VUVLO	Input UVLO	V <sub>IN</sub> rising		1.6	2.0	2.4	V
$\Delta V_{UVLO}$	Input UVLO Hysteresis	V <sub>IN</sub> decreasing		-	50	-	mV
ISHDN	Input Shutdown Current	Disabled, OUT = open		-	0.1	1	μA
lq	Input Quiescent Current	Enabled, OUT = open		-	60	100	μA
I <sub>LEAK</sub>	Input Leakage Current	Disabled, OUT grounded		-	0.1	1	μA
IREV	Reverse Leakage Current	Disabled, $V_{IN} = 0V$ , $V_{OUT} = 5$	V, I <sub>REV</sub> at V <sub>IN</sub>	-	0.01	1	μA
			T <sub>A</sub> = +25°C	-	70	84	
_		$V_{IN} = 5V, I_{OUT} = 2.0A$ -4	$-40^{\circ}C \le T_A \le +85^{\circ}C$	-	-	105	
RDS(ON)	Switch On-Resistance		T <sub>A</sub> = +25°C	-	90	108	mΩ
		$V_{IN} = 3.3V, I_{OUT} = 2.0A$	-40°C ≤ T <sub>A</sub> ≤ +85°C	-	-	135	
ILIMIT	Over-Load Current Limit (Note 6)	V <sub>IN</sub> = 5V, V <sub>OUT</sub> = 4.5V	-40°C ≤ T <sub>A</sub> ≤ +85°C	2.05	2.50	2.85	А
I <sub>Trig</sub>	Current Limiting Trigger Threshold	Output current slew rate (<10		-	2.5	-	Α
ISHORT	Short-Circuit Current Limit	Enabled into short circuit		-	2.75	-	Α
T <sub>SHORT</sub>	Short-Circuit Response Time	$V_{OUT} = 0V$ to $I_{OUT} = I_{LIMIT}$ (OI	UT shorted to ground)	-	2	-	μs
VIL	EN Input Logic Low Voltage	$V_{\rm IN} = 2.7 V$ to 5.5 V		-	-	0.8	V
VIH	EN Input Logic High Voltage	$V_{IN} = 2.7V \text{ to } 5.5V$		2	-	-	V
ILEAK-EN	EN Input Leakage	$V_{IN} = 5V$ , $V_{EN} = 0V$ and 5.5V		-	0.01	1	μA
ILEAK-O	Output Leakage Current	Disabled, V <sub>OUT</sub> = 0V		-	0.5	1	μA
T <sub>D(ON)</sub>	Output Turn-On Delay Time	$C_{L}=1\mu F, R_{LOAD}=5\Omega$		-	0.1	-	ms
T <sub>R</sub>	Output Turn-On Rise Time	$C_{L}=1\mu F, R_{LOAD}=5\Omega$		-	0.6	1.5	ms
T <sub>D(OFF)</sub>	Output Turn-Off Delay Time	$C_{L}=1\mu F, R_{LOAD}=5\Omega$		-	0.1	-	ms
T <sub>F</sub>	Output Turn-Off Fall Time	$C_{L}=1\mu F, R_{LOAD}=5\Omega$		-	0.05	0.1	ms
R <sub>FLG</sub>	FLG Output FET on-Resistance	$I_{FLG} = 10 \text{mA}$		-	25	40	Ω
IFOH	FLG Off Current	V <sub>FLG</sub> = 5V		-	0.01	1	μA
T <sub>Blank</sub>	FLG Blanking Time	Assertion or deassertion due temperature condition	to overcurrent and over-	4	7	15	ms
T <sub>DIS</sub>	Discharge Time	$C_{L}$ = 1µF, $V_{IN}$ = 5V, disabled	to V <sub>OUT</sub> < 0.5V	-	0.6	-	ms
R <sub>DIS</sub>	Discharge Resistance (Note 7)	V <sub>IN</sub> = 5V, disabled, I <sub>OUT</sub> = 1m	A	-	105	-	Ω
T <sub>SHDN</sub>	Thermal Shutdown Threshold	Enabled		-	+140	-	°C
T <sub>HYS</sub>	Thermal Shutdown Hysteresis	-		-	+20	-	°C
		SO-8 (Note 8)		-	96	-	°C/W
		MSOP-8 (Note 8)		-	130	-	°C/W
θ <sub>JA</sub>	Thermal Resistance Junction-to-	MSOP-8-EP (Note 9)		-	92	-	°C/W
		U-DFN3030-8 (Note 9)		-	84	-	°C/W
		U-DFN2020-6 (Note 10)		-	90	-	°C/M

## $\label{eq:Electrical Characteristics} (@T_A = +25^{\circ}C, V_{IN} = +5V, C_{IN} = 0.1 \mu F, C_L = 1 \mu F, unless otherwise specified.)$

Notes: 6. Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

7. The discharge function is active when the device is disabled (when enable is de-asserted or during power-up power-down when VIN < VUVLO).

The discharge function offers a resistive discharge path for the external storage capacitor for limited time. 8. Device mounted on 2" x 2" FR-4 substrate PCB, 2oz copper, with minimum recommended pad layout. 9. Device mounted on 2" x 2" FR-4 substrate PCB, 2oz copper, with minimum recommended pad on top layer and thermal vias to bottom layer ground plane.

10. Device mounted on 1" x 1" FR-4 substrate PCB, 2oz copper, with minimum recommended pad on top layer and thermal vias to bottom layer ground.



## **Typical Performance Characteristics**

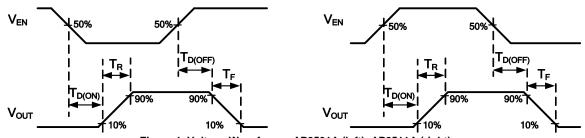
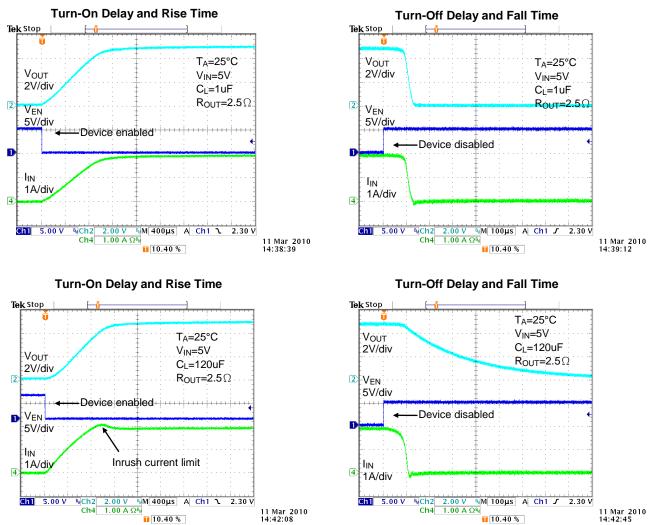


Figure 1. Voltage Waveforms: AP2501A (left), AP2511A (right)

All Enable Plots are for Enable Active Low



Ch1 5.00 V

Ch1 5.00 V

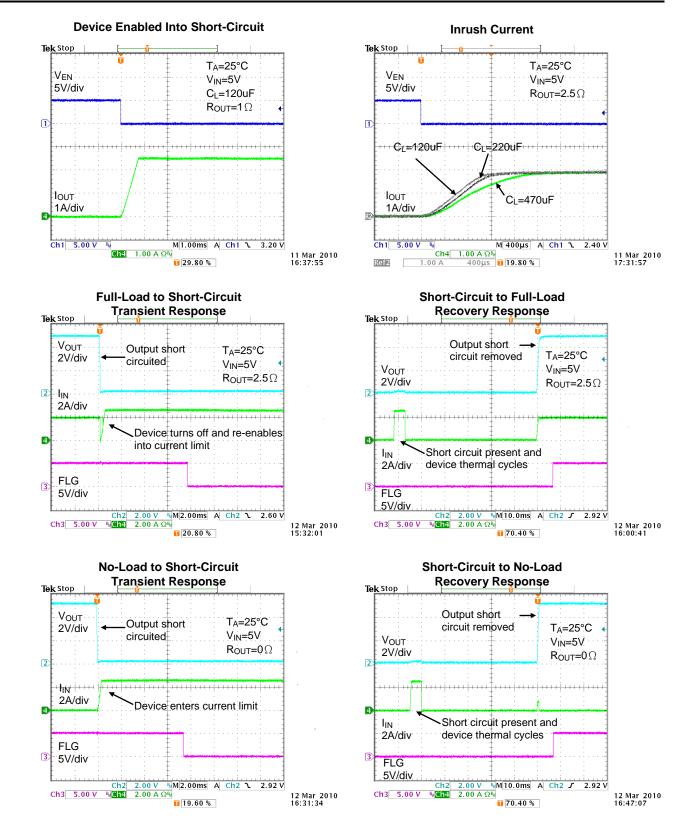
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11 Mar 2010 14:42:45

10.40 %

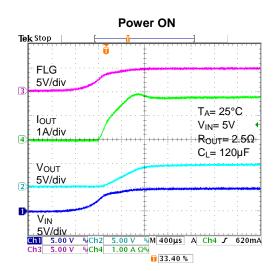


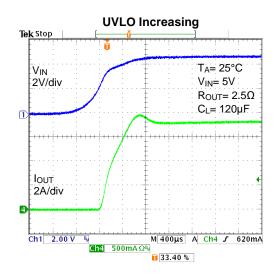
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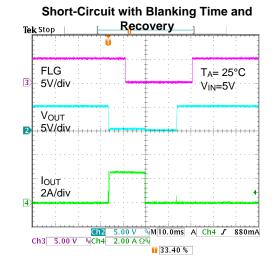


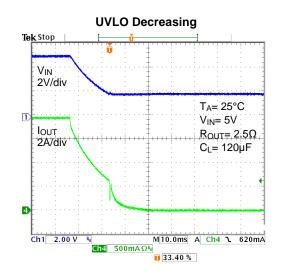


## Typical Performance Characteristics (cont.)



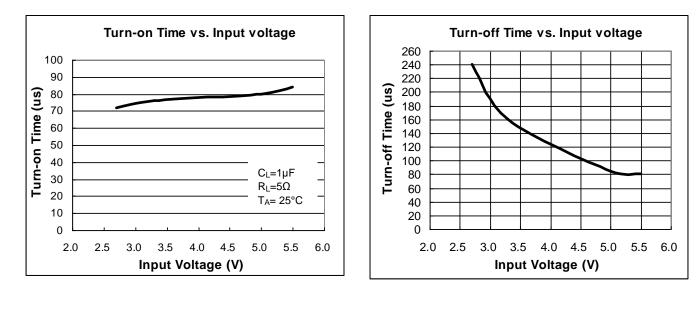


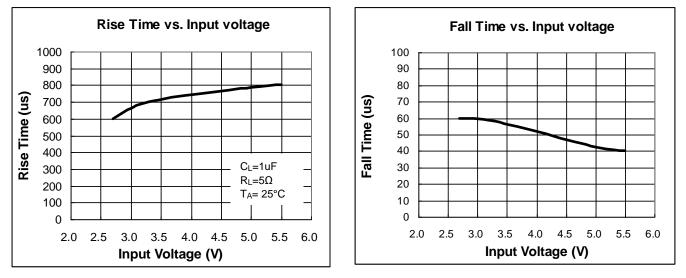






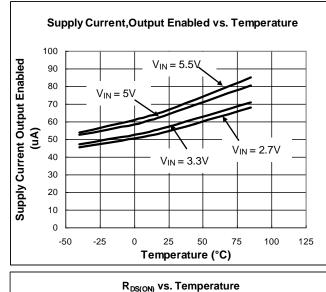
## Typical Performance Characteristics (cont.)

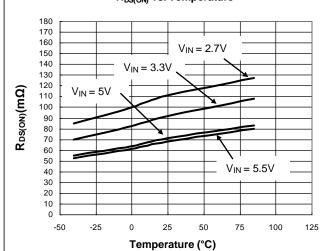


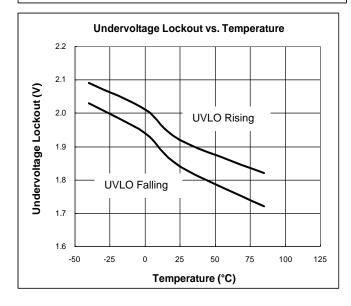


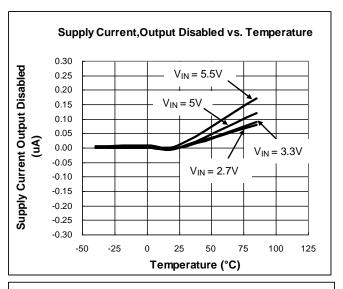


## Typical Performance Characteristics (cont.)

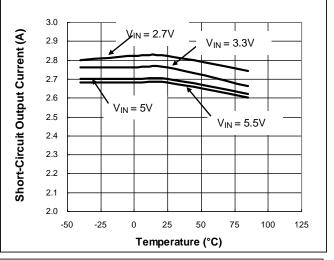


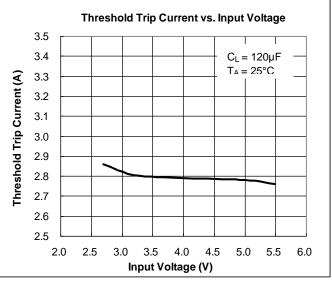














# AP2501A/AP2511A

## **Application Information**

#### **Power Supply Considerations**

A  $0.1\mu$ F to  $2.2\mu$ F X7R or X5R ceramic bypass capacitor placed between IN and GND, close to the device, is recommended. When an external power supply is used, or an additional ferrite bead is added to the input, high inrush current may cause voltage spikes higher than the device maximum input rating during short circuit condition. In this case, a  $2.2\mu$ F or larger capacitor is recommended. Placing a high-value electrolytic capacitor on the input and output pin(s) is recommended when the output load is heavy. This precaution reduces power-supply transients that may cause ringing on the input. Additionally, bypassing the output with a  $0.1\mu$ F to  $1.0\mu$ F ceramic capacitor improves the immunity of the device to short circuit transients.

#### **Overcurrent and Short Circuit Protection**

An internal sensing FET is employed to check for overcurrent conditions. Unlike current-sense resistors, sense FETs do not increase the series resistance of the current path. When an overcurrent condition is detected, the device maintains a constant output current and reduces the output voltage accordingly. Complete shutdown occurs only if the fault stays long enough to activate thermal limiting.

Three possible overload conditions can occur. In the first condition, the output has been shorted to GND before the device is enabled or before  $V_{IN}$  has been applied. The AP2501A/AP2511A senses the short circuit and immediately clamps output current to a certain safe level, namely I<sub>LIMIT</sub>. In the second condition, an output short or an overload occurs while the device is enabled. At the instance the overload occurs, higher inrush current may flow for a very short period of time before the current limit function can react. The input cancellater (a) residue the device is enabled.

current may flow for a very short period of time before the current limit function can react. The input capacitor(s) rapidly discharge through the device, activating current limit circuitry. Protection is achieved by momentarily opening the P-MOS high-side power switch and then gradually turning it on. After the current limit function has tripped (reached the overcurrent trip threshold), the device switches into current limiting mode and the current is clamped at I<sub>LIMIT</sub>.

In the third condition, the load has been gradually increased beyond the recommended operating current. The current is permitted to rise until the current-limit threshold (I<sub>TRIG</sub>) is reached or until the thermal limit of the device is exceeded. The AP2501A/AP2511A is capable of delivering current up to the current-limit threshold without damaging the device. Once the threshold has been reached, the device switches into its current limiting mode and is set at I<sub>LIMIT</sub>.

#### **FLG Response**

When an overcurrent or over-temperature shutdown condition is encountered, the FLG open-drain output goes active low after a nominal 7ms deglitch timeout. The FLG output remains low until both overcurrent and over-temperature conditions are removed. Connecting a heavy capacitive load to the output of the device can cause a momentary overcurrent condition, which does not trigger the FLG due to the 7ms deglitch timeout. The AP2501A/AP2511A is designed to eliminate false overcurrent reporting without the need of external components to remove unwanted pulses.

#### **Power Dissipation and Junction Temperature**

The low on-resistance of the internal MOSFET allows the small surface-mount packages to pass large current. Using the maximum operating ambient temperature (T<sub>A</sub>) and R<sub>DS(ON)</sub>, the power dissipation can be calculated by:

 $P_{\rm D} = R_{\rm DS(ON)} \times I^2$ 

Finally, calculate the junction temperature:

 $T_J = PD \; x \; R_{\theta JA} + T_A \label{eq:TJ}$  Where:

T<sub>A</sub>= Ambient Temperature °C

 $R_{\theta JA}$  = Thermal Resistance

P<sub>D</sub> = Total Power Dissipation

#### **Thermal Protection**

Thermal protection prevents the IC from damage when heavy-overload or short-circuit faults are present for extended periods of time. The AP2501A/AP2511A implements a thermal sensing to monitor the operating junction temperature of the power distribution switch. Once the die temperature rises to approximately +140°C due to excessive power dissipation in an overcurrent or short-circuit condition the internal thermal sense circuitry turns the power switch off, thus preventing the power switch from damage. Hysteresis is built into the thermal sense circuit, allowing the device to cool down approximately +20°C before the switch turns back on. The switch continues to cycle in this manner until the load fault or input power is removed. The FLG open-drain output is asserted when an over-temperature shutdown or overcurrent occurs with 7ms deglitch.

#### Undervoltage Lockout (UVLO)

Undervoltage Lockout (UVLO) function keeps the internal power switch from being turned on until the power supply has reached at least 2V, even if the switch is enabled. Whenever the input voltage falls below approximately 2V, the power switch is quickly turned off. This facilitates the design of hot-insertion systems where it is not possible to turn off the power switch before input power is removed.



### Application Information (continued)

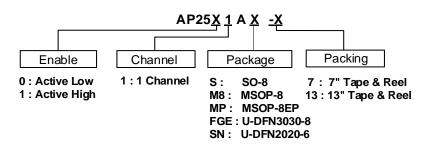
#### Discharge Function

The discharge function of the device is active when enable is disabled or de-asserted. The discharge function with the N-MOS power switch implementation is activated and offers a resistive discharge path for the external storage capacitor. This is designed for discharging any residue of the output voltage when either no external output resistance or load resistance is present at the output.

#### **Dual-Purpose Port Applications**

AP2501A/AP2511A is suitable for use in dual-purpose port applications in which a single port is used for data communication between the host and peripheral devices, while simultaneously maintaining a charge to the battery of the peripheral device. An example of this is a shared HDMI/MHL (Mobile High-Definition Link) port that allows streaming video between an HDTV or set-top box and a smartphone or tablet while maintaining a charge to the smartphone or tablet battery. In such dual-purpose port applications, it is important to insure <sub>VIN</sub> of the AP2501A/AP2511A is ramped to its operating voltage prior to enabling the output. Since the AP2501A/AP2511A includes an embedded discharge feature that discharges the output load of the device when the device is disabled, the batteries of the connected peripheral device will be subject to continual discharge whenever the AP2501A/AP2511A is disabled. An overstress condition to the device's discharge MOS transistor may result.

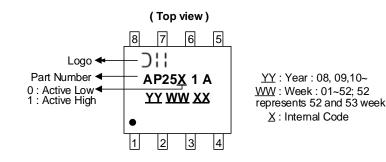
### **Ordering Information**



	Package Backaging	7"/13" Tape and Reel		
Part Number	Code	Packaging	Quantity	Part Number Suffix
AP25X1AS-13	S	SO-8	2,500/Tape & Reel	-13
AP25X1AM8-13	M8	MSOP-8	2,500/Tape & Reel	-13
AP25X1AMP-13	MP	MSOP-8EP	2,500/Tape & Reel	-13
AP25X1AFGE-7	FGE	U-DFN3030-8 Type E	3,000/Tape & Reel	-7
AP25X1ASN-7	SN	U-DFN2020-6	3,000/Tape & Reel	-7

### **Marking Information**

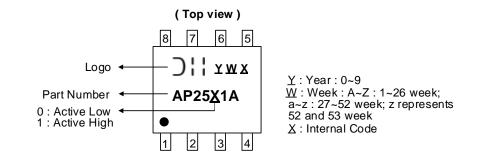
(1) SO-8



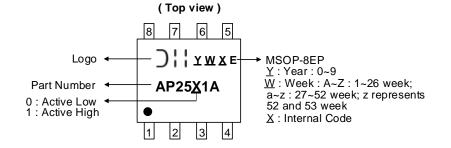


## Marking Information (continued)

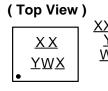
#### (2) MSOP-8



(3) MSOP-8EP



#### (3) U-DFN3030-8 Type E



Part Number	Package	Identification Code
AP2501AFGE-7	U-DFN3030-8	3W
AP2511AFGE-7	U-DFN3030-8	3X

#### (5) U-DFN2020-6

#### (Top View)



- XX : Identification Code
  - <u>Y</u> : Year : 0~9

 $\overline{W}$  : Week : A~Z : 1~26 week; a~z : 27~52 week; z represents 52 and 53 week

X : A~Z : Internal Code

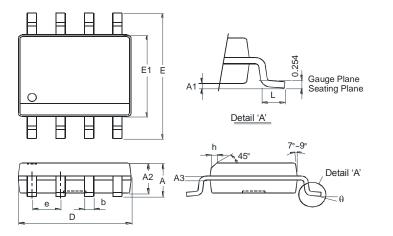
Part Number	Package	Identification Code
AP2501ASN-7	U-DFN2020-6	3Y
AP2511ASN-7	U-DFN2020-6	3Z



## Package Outline Dimensions (All dimensions in mm.)

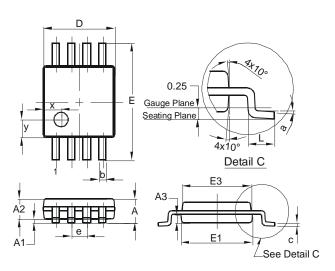
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

#### (1) Package type: SO-8



	SO-8					
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
E	5.90	6.10				
E1	3.85	3.95				
е	1.27	Тур				
h	-	0.35				
L	0.62	0.82				
θ	0°	8°				
All Dir	nensions	in mm				

#### (2) Package type: MSOP-8



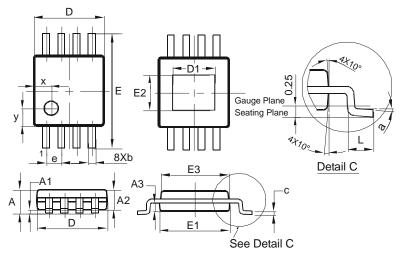
	MS	OP-8	
Dim	Min	Max	Тур
Α	-	1.10	-
A1	0.05	0.15	0.10
A2	0.75	0.95	0.86
A3	0.29	0.49	0.39
b	0.22	0.38	0.30
С	0.08	0.23	0.15
D	2.90	3.10	3.00
Е	4.70	5.10	4.90
E1	2.90	3.10	3.00
E3	2.85	3.05	2.95
e	-	-	0.65
L	0.40	0.80	0.60
а	0°	8°	4°
Х	-	-	0.750
у	-	-	0.750
	Dimen	sions	in mm



## Package Outline Dimensions (continued) (All dimensions in mm.)

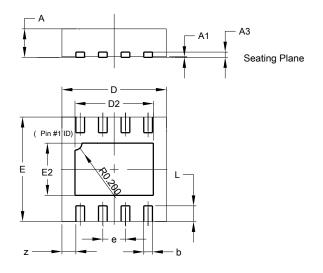
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

#### (3) Package type: MSOP-8EP

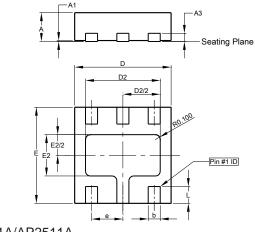


	MSOP	-8EP	
Dim	Min	Max	Тур
Α	-	1.10	-
A1	0.05	0.15	0.10
A2	0.75	0.95	0.86
A3	0.29	0.49	0.39
b	0.22	0.38	0.30
С	0.08	0.23	0.15
D	2.90	3.10	3.00
D1	1.60	2.00	1.80
Е	4.70	5.10	4.90
E1	2.90	3.10	3.00
E2	1.30	1.70	1.50
E3	2.85	3.05	2.95
е	-	-	0.65
L	0.40	0.80	0.60
а	0°	8°	4°
х	-	-	0.750
У	-	-	0.750
All D	imensi	ons in	mm

#### (4) Package type: U-DFN3030-8 Type E



#### (5) Package type: U-DFN2020-6



U-DFN3030-8 (TYPE E)						
Dim	Dim Min Max Typ					
Α	0.57	0.63	0.60			
A1	0.00	0.05	0.02			
A3	-	-	0.15			
b	0.20	0.30	0.25			
D	2.95	3.05	3.00			
D2	2.15	2.35	2.25			
E	2.95	3.05	3.00			
E2	1.40	1.60	1.50			
е	-	-	0.65			
L	0.30	0.60	0.45			
z	-	-	0.40			
All	Dimens	ions in r	nm			

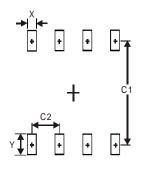
U-DFN2020-6				
Dim	Min	Max	Тур	
Α	0.57	0.63	0.60	
A1	0	0.05	0.03	
A3	_	_	0.15	
b	0.20	0.30	0.25	
D	1.95	2.075	2.00	
D2	1.45	1.65	1.55	
е			0.65	
E	1.95	2.075	2.00	
E2	0.76	0.96	0.86	
L	0.30	0.40	0.35	
All Dimensions in mm				



## **Suggested Pad Layout**

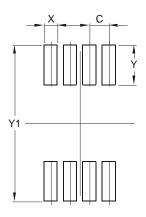
Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

### (1) Package type: SO-8



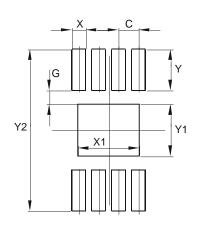
Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27

(2) Package type: MSOP-8



Dimensions	Value (in mm)
С	0.650
Х	0.450
Y	1.350
Y1	5.300

(3) Package type: MSOP-8EP



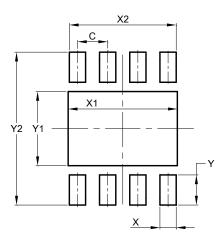
Dimensions	Value (in mm)
С	0.650
G	0.450
Х	0.450
X1	2.000
Ý	1.350
Y1	1.700
Y2	5.300



## Suggested Pad Layout (continued)

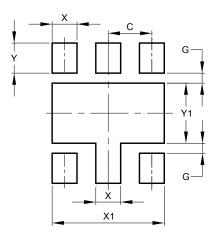
Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

### (4) Package type: U-DFN3030-8 Type E



Dimensions	Value
	(in mm)
С	0.650
Х	0.350
X1	2.350
X2	2.300
Y	0.650
Y1	1.600
Y2	3.300

### (5) Package type: U-DFN2020-6



Dimensions	Value
Dimensions	(in mm)
С	0.65
G	0.15
Х	0.37
X1	1.67
Y	0.45
Y1	0.90



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